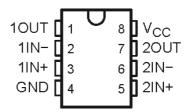
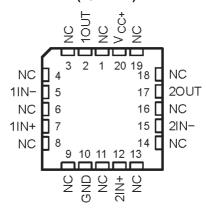


- Wide Supply Range:
- Single Supply...3V to 32V (26V for LM2904)
- or Dual Supplies ...±1.5V to ±16V (±13V for LM2904)
- Low Supply-Current Drain, Independent of Supply Voltage... 0.7mA Typ
- Common-Mode Input Voltage Range Includes Ground, Allowing Direct Sensing Near Ground
- Low Input Bias and Offset Parameters:
  - -Input Offset Voltage...3mV Typ
    - A versions...2mV Typ
  - -Input Offset Current...2nA Typ
  - -Input Bias Current...20nA Typ
    - A Versions...15nA Typ
- Differential Input Voltage Range Equal to Maximum-Rated Supply Voltage...32V (26V for LM2904)
- Open-Loop Differential Voltage Amplification...100
   V/mV Typ
- Internal Frequency Compensation

LM158, LM158A ... JG PACKAGE
LM258, LM258A ... D, DGK, OR P PACKAGE
LM358 ... D, DGK, P , PS, OR PW PACKAGE
LM358A ... D, DGK, P , OR PW PACKAGE
LM2904 ... D, DGK, P , PS, OR PW PACKAGE
(TOP VIEW)



LM158,LM158A ... FW PACKAGE (TOP VIEW)



**NC-No internal connection** 

#### **Description/ordering information**

These devices consist of two independent, high-gain, frequency-compensated operational amplifiers designed to operate from a single supply over a wide range of voltages. Operation from split supplies also is possible if the difference between the two supplies is 3V to 32V (3V to 26V for the LM2904), and  $V_{CC}$  is at least 1.5V more positive than the input common-mode voltage. The low supply-current drain is independent of the magnitude of the supply voltage.

Applications include transducer amplifiers, dc amplification blocks, and all the conventional operational amplifier circuits that now be implemented more easily in single-supply-voltage systems. For example, these devices can be operated directly from the standard 5-V supply used in digital systems and easily can provide the required interface electronics without additional ±5-V supplies.



### **Description/ordering information (continued)**

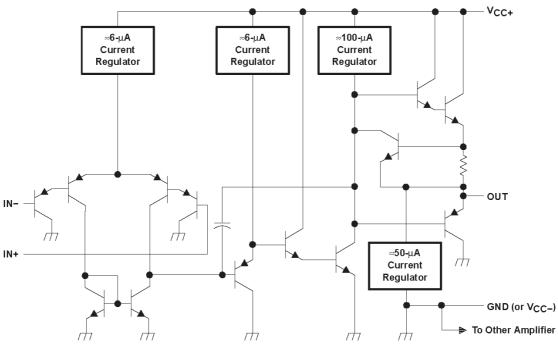
#### **ORDERING INFORMATION**

ONDERING INI ONMATION								
	TA V <sub>IO</sub> MAX TESTED V <sub>CC</sub>			PACKA	GE <sup>†</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
				PDIP (P)	Tube of 50	LM358P	LM358P	
				0010 (D)	Tube of 75	LM358D	1.14050	
				SOIC (D)	Reel of 2500	LM358D	LM358	
		7mV	30V	SOP (PS)	Reel of 2000	LM358PSR	L358	
				TCCOD (DM)	Tube of 150	LM358PW	1.250	
				TSSOP (PW)	Reel of 2000	LM358PWR	L358	
0	to 70			MSOP/VSSOP (DGK)	Reel of 2500	LM358DGKR	M5_‡	
				PDIP (P)	Tube of 50	LM358AP	LM358AP	
				SOIC(D)	Tube of 75	LM358AD	LM358A	
		3mV	30V	301C(D)	Reel of 2500	LM358ADR	LIVISSOA	
		Silly	30 V	TSSOP(PW)	Tube of 150	LM358APW	L358A	
				1330F(FW)	Reel of 2000	LM358APWR		
				MSOP/VSSOP(DGK)	Reel of 2500	LM358ADGKR	М6_‡	
	to 85	5mV	30V	PDIP (P)	Tube of 50	LM258P	LM258P	
				SOIC (D)	Tube of 75	LM258D	LM258	
		Silly		3010 (D)	Reel of 2500	LM258DR		
-25				MSOP/VSSOP (DGK)	Reel of 2500	LM258DGKG	M2_‡	
-23			30V	PDIP(P)	Tube of 50	LM258AP	LM258AP	
		3mV		SOIC (D)	Tube of 75	LM258AD	LM258A	
		Oniv		, ,	Reel of 2500	LM258ADR		
				MSOP/VSSOP (DGK)	Reel of 2500	LM258ADGKR	мз_‡	
				PDIP (P)	Tube of 50	LM2904P	LM2904P	
				SOIC (D)	Tube of 75	LM2904D	LM2904	
				0010 (B)	Reel of 2500	LM2904DR		
		7mV	26V	SOP (PS)	Reel of 2000	LM2904PSR	L2904	
				TSSOP (PW)	Tube of 150	LM2904PW	L2904	
-40	to 125			10001 (1 11)	Reel of 2000	LM2904PWR	MB_‡	
				MSOP/VSSOP (DGK)	Reel of 2500	LM2904DGKR	L2904V	
		7mV	32V	SOIC (D)	Reel of 2500	LM2904VQDR	L2904V	
		71110	32 V	TSSOP (PW)	Reel of 2000	LM2904VQPWR	L2904V	
		2mV	32V	SOIC (D)	Reel of 2500	LM2904AVQDR	L2904AV	
		∠mv	mv 32V	TSSOP (PW)	Reel of 2000	LM2904AVQPWR	L2904AV	
		5mV	30V	CDIP (JG)	Tube of 50	LM158JG	LM158JG	
-55	to 125	SITIV	30 v	LCCC (FK)	Tube of 55	LM158FK	LM158FK	
-33	10 120	2mV	30V	CDIP (JG)	Tube of 50	LM158AJG	LM158AJG	
		Z111 V	307	LCCC (FK)	Tube of 55	LM158AFK	LM158AFK	

### Symbol (each amplifier)



#### schematic (each amplifier)



COMPONENT COUNT						
Epi -FET	1					
Diodes	2					
Resistors	7					
Transistors	51					
Capacitors	2					



Absolute maximum ratings over operating free-air temperature range (unless otherwise noted) †

Absolute maximum ratings over operating free-air temperatu	re range (unless of	nerwise noted)				
		LM158, LM158A				
		LM258,LM258A	LM2904	UNIT		
		LM358,LM358A	LIVI2904	UNIT		
		LM2904V				
Supply voltage. V <sub>CC</sub> (see Note 1)	±16 or 32	±13 or 26	V			
Differential input voltage. V <sub>ID</sub> (see Note 2)		±32	±26	V		
Input voltage, V <sub>I</sub> (either input)		-0.3 to 32	-0.3 to 26	V		
Duration of output short circuit (one amplifier) to ground		l Imlianita d	lina ita al			
At (or below) 25 free-air temperature ( $V_{CC} \le 15V$ ) (see Notes 3	)	Unlimited	unlimited			
	D package	97	97			
	DGK package	172	172	/W		
Package thermal impedance, $\Theta_{JA}$ (see Notes 4 and 5)	P package	85	85			
	PS package	95	95			
	PW package	149	149			
Deckage thermal impedance (A. (ace Notes 6 and 7)	FK package	5.61		/W		
Package thermal impedance, $\Theta_{JA}$ (see Notes 6 and 7)	JG package	14.5		/ V V		
	LM158, LM158A	-55 to 125				
Operating free air temperature range. T	LM258, LM258A	-25 to 85				
Operating free-air temperature range, T <sub>A</sub>	LM358, LM358A	0 to 70				
	LM2904	-40 to 125	-40 to 125			
Operating virtual junction temperature, T <sub>J</sub>		150	150			
Case temperature for 60 seconds	FK package	260				
Lead temperature 1,6mm (1/16 inch) from case for 60 seconds	JG package	300	300			
Storage temperature range, T <sub>Stg</sub>		-60 to 150	-65 to 150			

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.



Electrical characteristics at specified free-air temperature, V<sub>CC</sub> =5V (Unless otherwise noted)

PARAMETER		TEST CONDITIONS†		T <sub>A</sub> ‡	LM158 LM258			LM358			UNIT	
				,	MIN	TYP§	MAX	MIN	TYP§	MAX		
V <sub>IO</sub>	Input offset voltage	$V_{CC}$ =5V to N $V_{IC}$ = $V_{ICR}$ (		25		3	5		3	7	mV	
	Average temperature coefficient of input offset voltage	V <sub>O</sub> =1.4V		Full range Full range		7	7		7	9	μV/	
I <sub>IO</sub>	Input offset current	V <sub>O</sub> =1.4V		25 Full range		2	30 100		2	50 150	nA	
a <sub>IIO</sub>	Average temperature coefficient of input offset current			Full range		10			10		pA/	
I <sub>IB</sub>	Input bias current	V <sub>O</sub> =1.4V		25 Full range		-20	-150 -300		-20	-250 -500	nA	
V <sub>ICR</sub> Common-mode		Vo a=5 V to	MAY	25	0 to V <sub>CC</sub> -	1.5		0 to V <sub>CC</sub> -1	1.5		- v	
Input voltage range	Input voltage range	V <sub>CC</sub> =5 V to MAX		Full range	0 to V <sub>CC</sub> -			0 to V <sub>CC</sub> -2	2		V	
V <sub>OH</sub>	High-level	R <sub>L</sub> ≥2KΩ R <sub>L</sub> ≥10KΩ		25 25	V <sub>CC</sub> -	1.5		V <sub>CC</sub> -1	1.5		- V	
	Output voltage	VCC=MAX	R <sub>L</sub> =2KΩ R <sub>L</sub> ≥10KΩ	Full range Full range	26 27	28		26 27	28		-	
V <sub>OH</sub>	Low-level Output voltage	R <sub>L</sub> ≤10kΩ	112-101122	Full range		5	20		5	20	mV	
AVD	Large-signal differential	VCC=1.5V, VO=1V to 11	IV,	25	50	100		25	100		V/mV	
CMRR	Voltage amplification  Common-mode  Rejection ratio	R <sub>L</sub> ≥2kΩ V <sub>CC</sub> =5V to N V <sub>IC</sub> =V <sub>ICR</sub> (mi		Full range 25	70	80		15 65	80		dB	
K <sub>SVR</sub>	Supply-voltage rejection ratio ( V <sub>DD</sub> / V <sub>IO</sub> )	V <sub>CC</sub> =5V to N		25	65	100		65	100		dB	
V <sub>O1</sub> /V <sub>O2</sub>	Crosstalk attenuation	F=1kHz to 2	0kHz	25		120			120		dB	
		V <sub>CC</sub> =15V V <sub>ID</sub> =1V	Source	25	-20	-30		-20	-30			
lo	Output current	V <sub>O</sub> =0		Full range	-10			-10			mA	
		V <sub>CC</sub> =15V V <sub>ID</sub> =-1V	Sink	25	10	20		10	20			
laa	Output ourrent	V <sub>O</sub> =15V	-200m\/	Full range	5	30		5	20		μ.Λ	
I <sub>OS</sub> I <sub>OS</sub>	Output current Short-circuit Output current	$V_{ID} = -1V_1V_0$ $V_{CC}$ at 5V, 0 $V_0=0$		25 25	12	30 ±40	±60	12	30 ±40	±60	μA mA	
I <sub>CC</sub>	Supply current (two amplifiers)	$V_O=0$ $V_O=2.5V,No$ $V_{CC}=MAX,$		Full range		0.7	1.2		0.7	1.2	mA	

 $<sup>\</sup>dagger$ All characteristics are measured under open-loop conditions, with zero common-mode input voltage, unless otherwise specified. MAX V<sub>CC</sub> for testing purposes is 26V for the LM2904 and 30V for others.

 $<sup>\</sup>ddagger$ Full range is -55 to 125 for LM158, -25 to 85 for LM258, 0 to 70 for LM358, and -40 to 125 for LM2904. §All typical values are at  $T_A$ =25 .



### Electrical characteristics at specified free-air temperature, V<sub>CC</sub>= 5V (unless otherwise noted)

PARAMETER		TEST CONDITIONS <sup>†</sup>		TA <sup>‡</sup>		LM2904		UNIT	
	PARAMETER	TEST CON	DITIONS	IA+	MIN	TYP§	MAX	UNIT	
		V <sub>CC</sub> =5V to MAX,	Non-A devices	25		3	7		
$V_{IO}$	Input offset voltage	$V_{IC}=V_{ICR}(min),$	Non-A devices	Full range			10	mV	
VΙΟ	input onset voltage	$V_{O}=1.4V$	A-suffix	25		1	2	IIIV	
		VO-1.4V	devices	Full range			4		
a <sub>VIO</sub>	Average temperature coefficient of input offset voltage			Full range		7		μV/	
			Non-V device	25		2	50		
	In a start assument	\/ -4 4\/	Non-v device	Full range			300	^	
I <sub>IO</sub> I	Input offset current	V <sub>O</sub> =1.4V	\/ auffix dayiaa	25		2	50	nA	
			V-suffix device	Full range			150		
al <sub>IO</sub>	Average temperature coefficient of input offset current			Full range		10		pA/	
	land biograms at	V 4.4V		25		-20	-250	^	
I <sub>IB</sub>	Input bias current	V <sub>O</sub> =1.4V		Full range			-500	nA	
V <sub>ICR</sub>	Common-mode input voltage	\/ =5\/+0 MAY		25	0 to V <sub>CC</sub> – 1	.5		V	
	range	V <sub>CC</sub> =5V to MAX		Full range	0 to V <sub>CC</sub> -2			V	
		R <sub>L</sub> ≥10KΩ		25	V <sub>CC</sub> -1.	5			
	High-level output voltage	V <sub>CC</sub> =MAX,	$R_L=2k\Omega$	Full range	22				
$V_{OH}$		Non-V device	R <sub>L</sub> ≥10kΩ	Full range	23	24		V	
		V <sub>CC</sub> =MAX,	$R_L=2k\Omega$	Full range	26				
		V-suffix device	R <sub>L</sub> ≥10kΩ	Full range	27	28			
V <sub>OL</sub>	Low-level output voltage	R <sub>L</sub> ≤10KΩ		Full range		5	20	mV	
$A_{VD}$	Large-signal differential	V <sub>CC</sub> =15V,V <sub>O</sub> =1V to	o 11V	25	25	100		V/mV	
	Voltage amplification	R <sub>L</sub> ≤2kΩ		Full range	15			V/IIIV	
CMRR	Common-mode rejection ratio	V <sub>CC</sub> =5V to MAX,	Non-V device	25	50	80		dB	
CIVIKK	Common-mode rejection ratio	V <sub>IC</sub> =V <sub>ICR</sub> (min)	V-suffix device	25	65	80		uБ	
k <sub>SVR</sub>	Supply-voltage rejection ratio ( V <sub>DD</sub> / V <sub>IO</sub> )	V <sub>CC</sub> =5V to MAX		25	65	100		dB	
V <sub>O1</sub> /V <sub>C</sub>	Crosstalk attenuation	f=1kHz to 20kHz		25		120		dB	
		V <sub>CC</sub> =15V,	Carrag	25	-20	-30			
		$V_{ID}$ =1V, $V_{O}$ =0	Source	Full range	-10				
l <sub>O</sub>	Output current	V <sub>CC</sub> =15V, V <sub>ID</sub> =-1V,	Sink	25	10	20		mA	
•	·	V <sub>O</sub> =15V		Full range	5				
		V <sub>ID</sub> =-1V,	Non-V device	25		30			
		V <sub>O</sub> =200mV	V-suffix device	25	12	40		μA	
IOS	Short-circuit output current	V <sub>CC</sub> at 5V, GND at	: –5V, V <sub>O</sub> =0	25		±40	±60	mA	
	Owner to the second of the sec	V <sub>O</sub> =2.5V, No load	-	Full range		0.7	1.2	^	
$I_{CC}$	Supply current (two amplifiers)	V <sub>CC</sub> =MAX, V <sub>O</sub> =0.5	5V, No load	Full range		1	2	mA	

 $\dagger$ All characteristics are measured under open-loop conditions, with zero common-mode input voltage. Unless otherwise specified. MAX V<sub>CC</sub> for testing purposes is 26V for the LM2904, 32V for the LM2904V, and 30V for others.

 $\ddagger$ Full range is -55 to 125 for LM158, -25 to 85 for LM258, 0 to 70 for LM358, and -40 to 125 for LM2904. §All typical values are at  $T_A$ =25



### Electrical characteristics at specified free-air temperature, Vcc=5V (unless otherwise noted)

	DADAMETED	TEGT COM	DITIONOT	<b>-</b> +		LM158A	<b>A</b>		LM258A	L	LINUT
	PARAMETER	TEST CON	DITIONS	T <sub>A</sub> ‡	MIN	TYP§	MAX	MIN	TYP§	MAX	UNIT
		V <sub>CC</sub> =5V to 30		25			2		2	3	
$V_{IO}$	Input offset voltage	$V_{IC}=V_{ICR(min)}$ $V_{O}=1.4V$	,	Full range			4			4	mV
	Average	V <sub>O</sub> -1.4V		T dil Taligo			•			•	
a <sub>VIO</sub>	temperature coefficient of			Full range		7	15*		7	15	μV/
	input offset voltage			25		2	10		2	15	
$I_{10}$	Input offset current	V <sub>O</sub> =1.4V		Full range			10 30			15 30	nA
a <sub>VIO</sub>	Average temperature coefficient of input offset voltage			Full range		10	200		10	200	pA/
$I_{IB}$	Input bias current	V <sub>O</sub> =1.4V		25		-15	-50		-15	-80	nA
ID		VO 1.1V		Full range			-100	_		-100	117 (
$V_{ICR}$	Common-mode	V <sub>CC</sub> =30V		25	0 to V <sub>CC</sub> -1	1.5		0 to V <sub>CC</sub> -	-1.5		V
	Input voltage range			Full range	0 to V <sub>CC</sub> –2	)		0 to V <sub>CC</sub> -	-2		
.,		R <sub>L</sub> ≥2kΩ		25	V <sub>CC</sub> -1			V <sub>CC</sub> -			
V <sub>OH</sub>	High-level Output voltage	V <sub>CC</sub> =30V	R <sub>L</sub> =2kΩ	Full range	26			26		V	V
		VCC 001	R <sub>L</sub> ≥10kΩ	Full range	27	28		27	28		
V <sub>OL</sub>	Low-level Output voltage	R <sub>L</sub> ≤10kΩ		Full range		5	20		5	20	mV
$A_{VD}$	Large-signal differential	$V_{CC}$ =15V, $V_{O}$ =1V to 11V	,	25	50	100		50	100		V/mV
	Voltage amplification	R <sub>L</sub> ≥2kΩ		Full range	25			25			
CMRF	R Common-mode Rejection ratio			25	70	80		70	80		dB
k <sub>SVR</sub>	Supply-voltage rejection ratio ( V <sub>DD</sub> / V <sub>IO</sub> )			25	65	100		65	100		dB
V <sub>01</sub> /V <sub>0</sub>	O2 Crosstalk attenuation	f=1 kHz to 20k	кНz	25		120			120		dB
		V <sub>CC</sub> =15V, V <sub>ID</sub> =1V,	Source	25	-20	-30	-60	-20	-30	-60	
		V <sub>O</sub> =0		Full range	-10			-10			
lo	Output current	V <sub>CC</sub> =15V, V <sub>ID</sub> =-1V,	Sink	25	10	20		10	20		mA
		V <sub>O</sub> =15		Full range	5			5			
		V <sub>ID</sub> =-1V, V <sub>O</sub> =2		25	12	30		12	30		
los	Short-circuit output current	V <sub>CC</sub> at 5V, GN V <sub>O</sub> =0		25		±40	±60		±40	±60	mA
Icc	Supply current (two	V <sub>O</sub> =2.5V, No I		Full range		0.7	1.2		0.7	1.2	
-00	amplifiers)	V <sub>CC</sub> =MAX, VO No load	D=0.5V,	Full range		1	2		1	2	mA

<sup>\*</sup>On products compliant to MIL-PRF-38535, this parameter is not production tested.

<sup>†</sup>All characteristics are measured under open-loop conditions. With zero common-mode input voltage. Unless otherwise specified. Max Vcc for testing purposes is 26V for LM2904 and 30V for others.

Full range is -55 for LM158A, -25 to 85 for LM258A, and 0 to 70 for LM358A.

<sup>§</sup>All typical values are at  $T_A = 25$  ,



electrical characteristics at specified free-air temperature,  $V_{CC}$  =5V (unless otherwise noted)

DADAMETED	TEST CONDITIONS	<b>-</b> †	LM358A			LINUT	
PARAMETER	TEST CONDITIONS <sup>†</sup>	T <sub>A</sub> ‡	MIN	TYP§	MAX	UNIT	
V <sub>IO</sub> Input offset voltage	V <sub>CC</sub> =5V to 30V, V <sub>IC</sub> =V <sub>ICR(min)</sub> ,	25		2	3	mV	
V <sub>IO</sub> input onset voltage	V <sub>O</sub> =1.4V	Full range			5	- 111V	
Average temperature coefficient of a <sub>VIO</sub> input offset voltage		Full range		7	20	μV/	
I <sub>IO</sub> Input offset current	V <sub>O</sub> =1.4V	25 Full range		2	30 75	nA	
Average temperature coefficient of a <sub>VIO</sub> input offset voltage		Full range		10	300	pA/	
I <sub>IB</sub> Input bias current	V <sub>O</sub> =1.4V	25 Full range		-15	-100 -200	nA	
V <sub>ICR</sub> Common-mode Input voltage range	V <sub>CC</sub> =30V	25	0 to V <sub>CC</sub> -1	.5	200	V	
VICR Common-mode input voltage range	vCC=30 v	Full range	0 to V <sub>CC</sub> –2				
	R <sub>L</sub> ≥2kΩ	25	V <sub>CC</sub> -1				
V <sub>OH</sub> High-level Output voltage	$V_{CC}=30V$ $R_L=2k\Omega$	Full range	26			V	
	R <sub>L</sub> ≥10kΩ	Full range	27	28			
V <sub>OL</sub> Low-level output voltage	R <sub>L</sub> ≤10kΩ	Full range		5	20	mV	
Large-signal differential  A <sub>VD</sub> Voltage amplification	$V_{CC}$ =15V, $V_{O}$ =1V to 11V, $R_1 \ge 2k\Omega$	25	50	100		V/mV	
	1/[=2//22	Full range	15			I.D.	
CMRR Common-mode Rejection ratio		25	65	80		dB	
$k_{SVR}$ Supply-voltage rejection ratio ( $V_{DD}/V_{IO}$ )		25	65	100		dB	
V <sub>01</sub> /V <sub>02</sub> Crosstalk attenuation	f=1 kHz to 20kHz	25		120		dB	
	V <sub>CC</sub> =15V, V <sub>ID</sub> =1V, Source	25	-20	-30	-60		
	V <sub>O</sub> =0	Full range	-10			m ^	
I <sub>O</sub> Output current	V <sub>CC</sub> =15V, V <sub>ID</sub> =-1V, Sink	25	10	20		– mA	
	V <sub>O</sub> =15	Full range	5				
	V <sub>ID</sub> =-1V, V <sub>O</sub> =200mV	25		30			
los Short-circuit output current	V <sub>CC</sub> at 5V, GND at –5V,V <sub>O</sub> =0	25		±40	±60	mA	
I <sub>CC</sub> Supply current (two amplifiers)	V <sub>O</sub> =2.5V, No load	Full range		0.7	1.2	mA	
	V <sub>CC</sub> =MAX, VO=0.5V,No load	Full range		1	2		

<sup>†</sup>All characteristics are measured under open-loop conditions, with zero common-mode input voltage, unless otherwise specified.MAX Vcc for testing purposes is 26V for LM2904 and 30V for others.

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 $All typical values are at T_A=25$  .

<sup>‡</sup>Full range is -55 to 125 for LM158A, -25 to 85 for LM258A, and 0 to 70 for LM358A,



### Operating conditions, $V_{CC} = \pm 15V$ , $T_A = 25$

	PARAMETER	TEST CONDITIONS	TYP	UNIT
SR	Slew rate at unity gain	$R_L$ =1M $\Omega$ ,CL =30pF, $V_I$ =±10V (see Figure 1)	0.3	V/µs
B1	Unity-gain bandwidth	$R_L$ =1M $\Omega$ ,CL =20pF, (see Figure 1)	0.7	MHz
Vn	Equivalent input noise voltage	$R_L$ =1M $\Omega$ , $V_I$ =±10V,f=1kHz (see Figure 2)	40	NV/ Hz

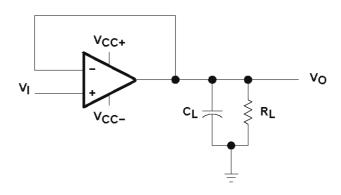


Figure 1. Unity-Gain Amplifier

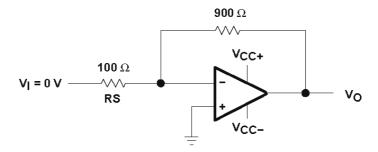
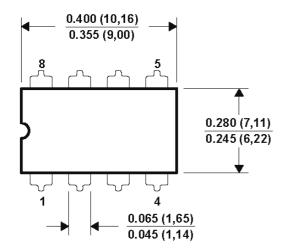
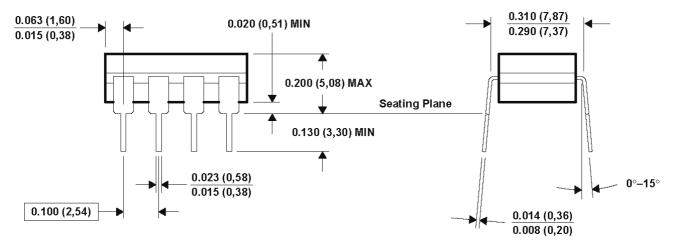


Figure 2. Noise-Test Circuit

JG (R-GDIP-T8) CERAMIC DUAL-IN-LINE

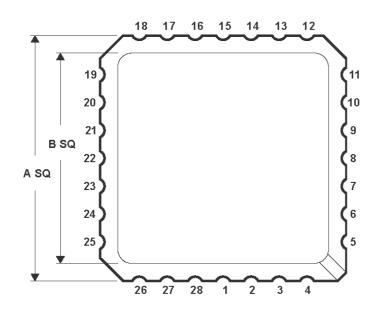




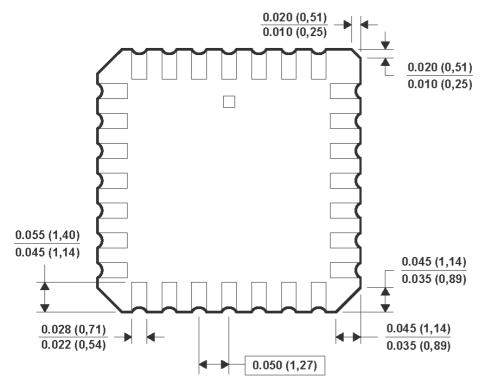
4040107/C 08/96

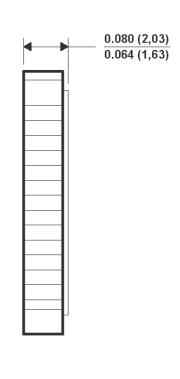
# FK (S-CQCC-N\*\*) 28 TERMINAL SHOWN

#### LEADLESS CERAMIC CHIP CARRIER



NO. OF		A	В			
TERMINALS **	MIN	MAX	MIN	MAX		
20	0.342	0.358	0.307	0.358		
	(8,69)	(9,09)	(7,80)	(9,09)		
28	0.442	0.458	0.406	0.458		
	(11,23)	(11,63)	(10,31)	(11,63)		
44	0.640	0.660	0.495	0.560		
	(16,26)	(16,76)	(12,58)	(14,22)		
52	0.739	0.761	0.495	0.560		
	(18,78)	(19,32)	(12,58)	(14,22)		
68	0.938	0.962	0.850	0.858		
	(23,83)	(24,43)	(21,6)	(21,8)		
84	1.141	1.165	1.047	1.063		
	(28,99)	(29,59)	(26,6)	(27,0)		

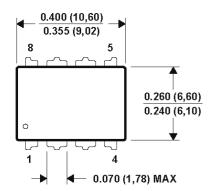


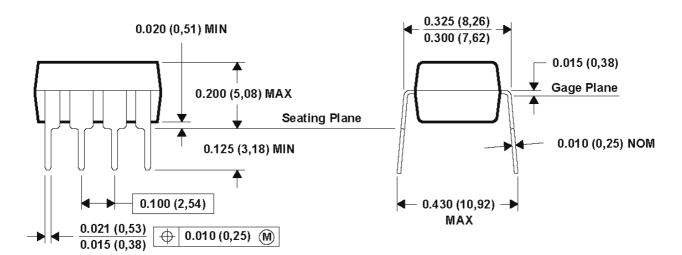


4040140/D 10/96

P (R-PDIP-T8)

PLASTIC DUAL-IN-LINE





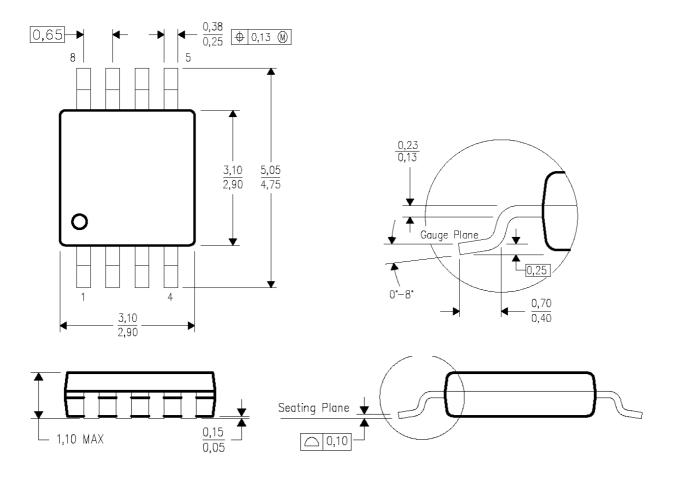
4040082/D 05/98

NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-001

### DGK (S-PDSO-G8)

#### PLASTIC SMALL-OUTLINE PACKAGE



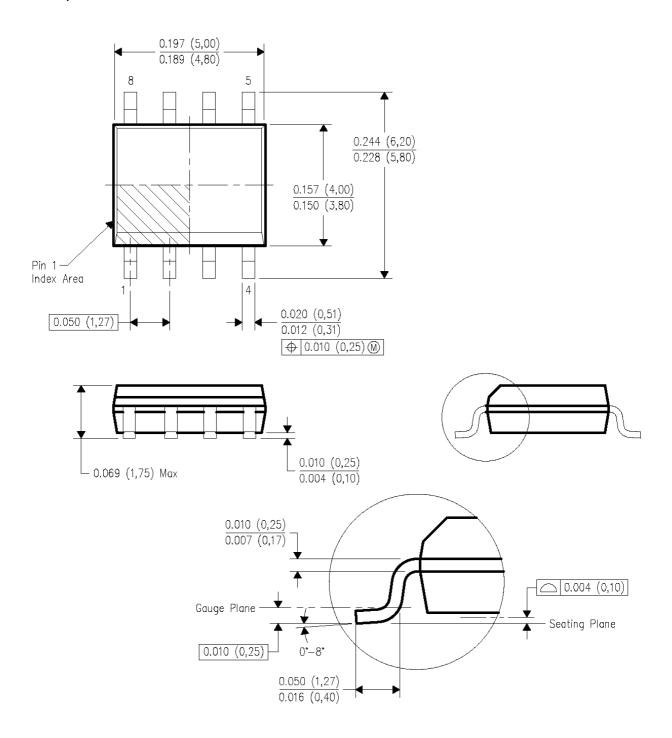
4073329/D 12/03

NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion.
- D. Falls within JEDEC MO-187 variation AA.

D (R-PDSO-G8)

#### PLASTIC SMALL-OUTLINE PACKAGE



4040047-2/F 07/2004

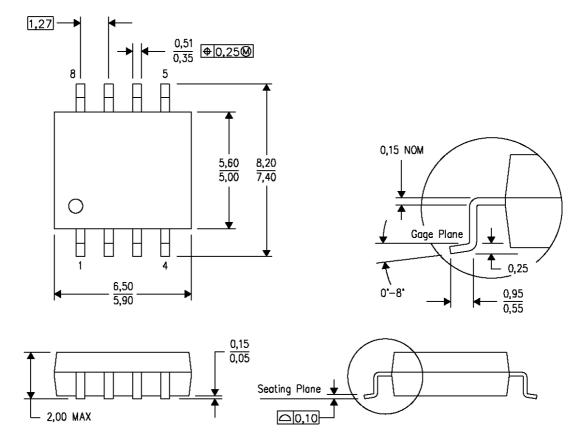
NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0.15).
- D. Falls within JEDEC MS-012 variation AA.

#### **MECHANICAL DATA**

### PS (R-PDSO-G8)

#### PLASTIC SMALL-OUTLINE PACKAGE



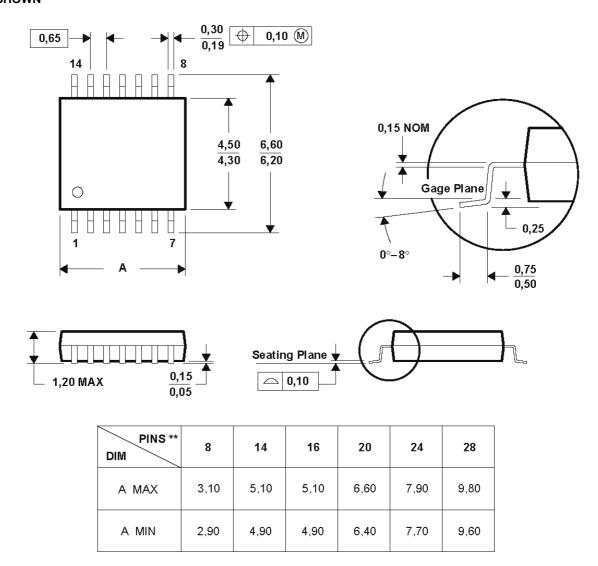
4040063/C 03/03

NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0.15.

# PS (R-PDSO-G\*\*) 14 PINS SHOWN

### PLASTIC SMALL-OUTLINE PACKAGE



4040064/F 01/97

NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.15.

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D. Falls within JEDEC MO-153